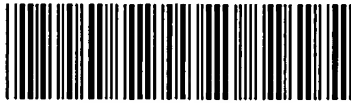


# Search Notes



Application/Control No.

10/781,370

Examiner

Lee Lum

Applicant(s)/Patent under Reexamination

MIYAKAWA ET AL.

Art Unit

3611

## SEARCHED

Class	Subclass	Date	Examiner
180	219-221		
		8/25/5	

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR